

# **Resonant cavity light emitting diodes**

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## **Outline**

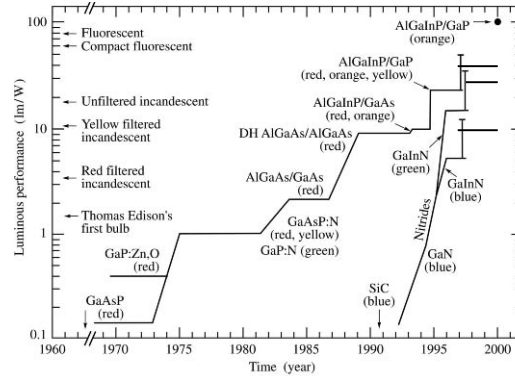
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- Introduction and history
- Spontaneous emission from resonant cavities
  - modification of spontaneous emission
  - reflectors
  - optical mode density in a one-dimensional resonator
  - spectral and integrated emission enhancement
- Resonant cavity light emitting diodes
  - RCLED design rules
  - AlGaInP/GaAs RCLED (650nm)
  - GaN/AlGaIn RCLED (510-570 nm)
- Conclusion
- Acknowledgements



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## Improvement in visible LED efficiency over the last forty years



efficiency improvements of 10x/decade over this timeframe



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## LED and RCLEDs

LED



RCLED



Resonant cavity LED (RCLED)  
Vertical cavity LED (VCLED)  
Microcavity LED (MCLED)

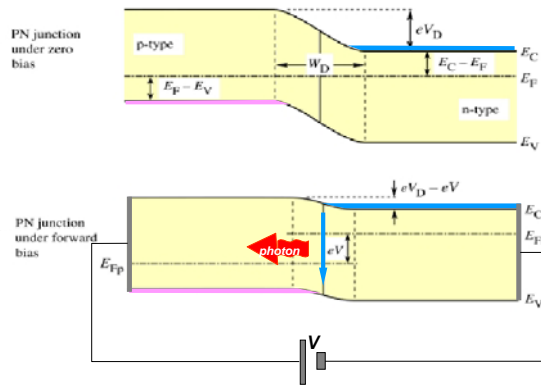


Surface emitter with forward-directed radiation



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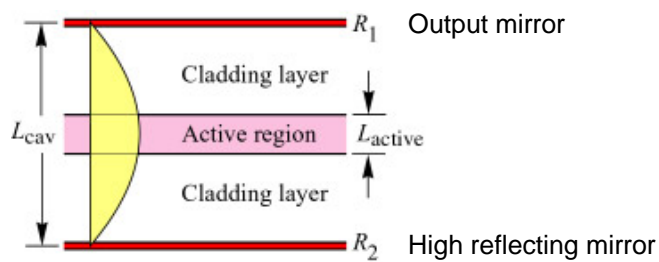
## LED – basic electrical properties



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## What's a Resonant Cavity LED?

Schematic illustration of a resonant cavity



The cavity length  $L_{cav}$  is equal to  $\lambda/2$



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## Advantages of RCLEDs

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Resonators provide LEDs with laser-like performance

Superior to conventional LEDs in :

- luminous intensity
- high directionality
- spatial coherence
- spectral purity (less chromatic dispersion)
- modulation capabilities

in comparison to laser light sources

- less temperature sensitive
- longer life time ( ~ 30 000 h)



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## Applications

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**Key technology** for next generation of data communication via polymethyl methacrylate (PMMA) **plastic optical fiber (POF)** in local networks for in-home multimedia

- **narrow-band services** like **phone** or **home automation**
- **broadband services** based on the POF IEEE1394b standard known as "**Firewire**" or "**i-link**" or **digital TV, PCs, DVD** and **Internet**
- **automotive applications** (media orientated system transport (MOST))



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## Plastic optical fiber (POF)

POF advantages over copper cables (22.5 Mbit/s):

- Immunity to EM and RF interference
- Absence of crosstalk between fibres
- Complete electronic isolation
- Higher data transmission capability (500 Mbit/s)
- Small size and light weight

POF compared to glass fibers:

- Lower costs
- More reliable and vibration tolerant fibre connectors (core diameter typically 0.5 - 1 mm)
- Easier installation and handling



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## POF – large core with good flexibility

### Plastic Optical Fiber

- Large Core: Up to 1mm
- Large Connectorization Tolerance
- Polishing-Free
- Flexible
- High N.A.



POF  
Polymer Core  
Polymer Clad

### Glass Optical Fiber

- Small Core: Up to 62.5µm
- Small Connectorization Tolerance
- Polishing
- Brittle & Fragile
- Low N.A.



GOF  
Silica Core  
Silica Clad

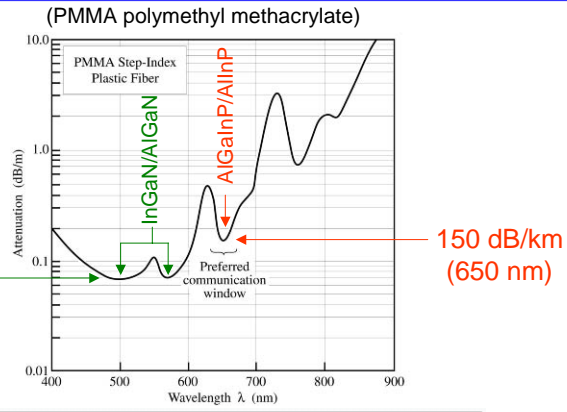


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## Attenuation of a PMMA step-index plastic optical fiber

**Silica fiber:**  
**0.15 dB/km**  
**(1.55  $\mu\text{m}$ )**

**70 dB/km**  
**(510 nm, 570 nm)**



<b>Wavelength</b>	525 nm	560 nm	650 nm
<b>Material dispersion</b>	700 ps / (nm km)	500 ps / (nm km)	320 ps / (nm km)

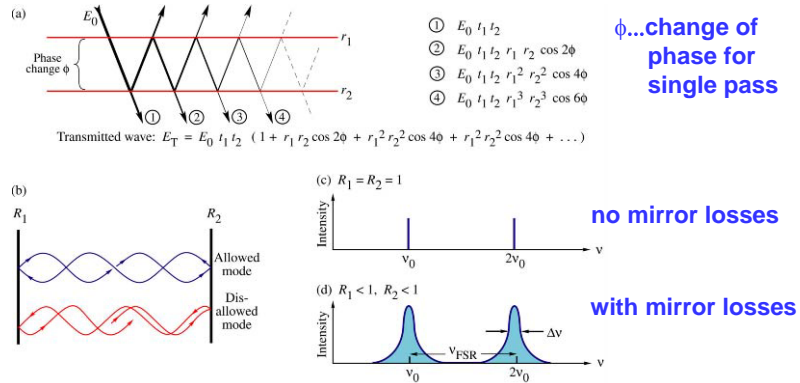


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Spontaneous emission from resonant cavities

## Fabry-Perot resonator

(for the electric field amplitude  $E_0$ )



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## Fabry-Perot cavities

**T** transmittance through FP-cavity:

$$T = \frac{T_1 T_2}{1 + R_1 R_2 - 2 \sqrt{R_1 R_2} \cos 2\phi}$$

**F** finess of FP cavity:

$$F = \frac{\text{Peak separation}}{\text{Peak width}} = \frac{\pi}{2 \phi_{1/2}} = \frac{\pi \sqrt[4]{R_1 R_2}}{1 - \sqrt{R_1 R_2}} \approx \frac{\pi}{1 - \sqrt{R_1 R_2}}$$

**Q** quality factor of FP cavity:

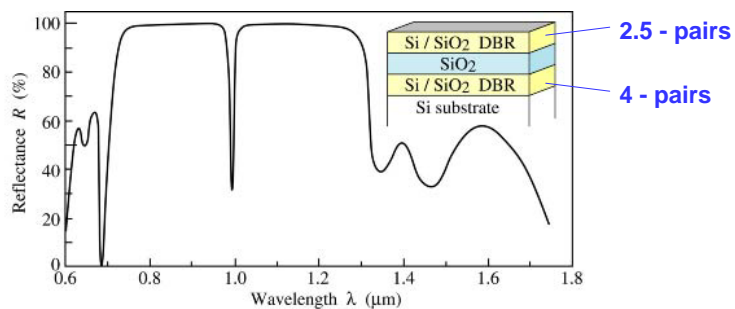
$$Q = \frac{\text{Peak frequency}}{\text{Peak width}} = \frac{2nL_c}{\lambda} \frac{\pi \sqrt[4]{R_1 R_2}}{1 - \sqrt{R_1 R_2}} \approx \frac{2nL_c}{\lambda} \frac{\pi}{1 - \sqrt{R_1 R_2}}$$

$$Q = \frac{2nL_c}{\lambda} F$$



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## Reflectance of a microcavity of two Si/SiO<sub>2</sub> reflectors and a SiO<sub>2</sub> center region

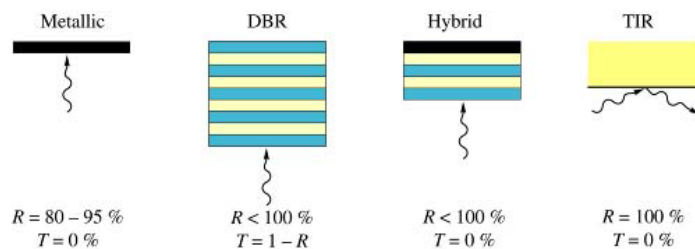


- the resonance wavelength of the cavity is  $\sim 1.0 \mu\text{m}$
- $R > 0$  at resonance due to unequalness of the reflectivities of mirrors



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## Reflectors



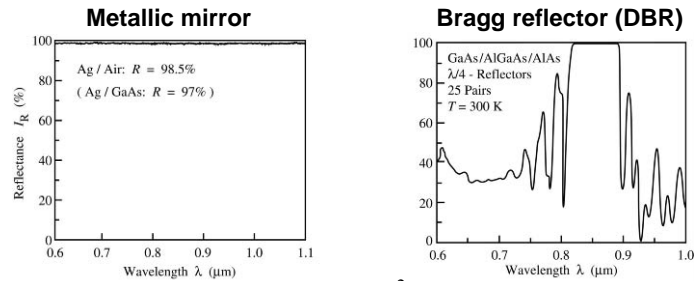
TIR ... Total internal reflector



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## Metallic and distributed Bragg reflectors



$$R_{DBR} = |r_{DBR}|^2 = \left( \frac{1 - \left(\frac{n_1}{n_2}\right)^{2m}}{1 + \left(\frac{n_1}{n_2}\right)^{2m}} \right)^2 \quad \Delta\lambda_{stop\ band} = \frac{2\lambda_{Bragg}\Delta n}{\pi n_{eff}}$$



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## Distributed Bragg Reflector (DBR)

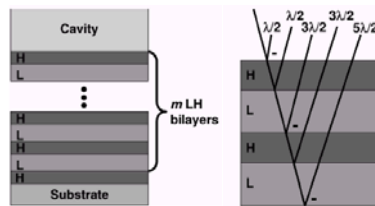


Figure 1. (a) Distributed Bragg reflector (DBR) structure using a high-refractive-index quarter-wave layer on the substrate followed by  $m$  low-index/high-index (LH) quarter-wave bilayers. (b) Relative phases at the DBR surface of light rays reflected from each interface within the DBR structure. The minus sign indicates the  $180^\circ$  phase shift that occurs upon reflection from a low- to high-index surface. A round-trip pass through each quarter-wave layer results in a half-wave phase shift. Every reflected ray returns to the DBR surface shifted by exactly  $180^\circ$  in phase. All reflected electric fields thus add constructively to give a high net reflectance for the DBR, even if individual interface reflectances are small.

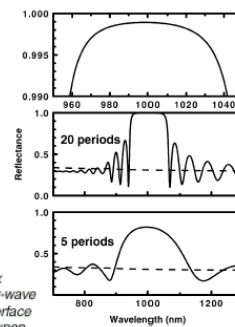


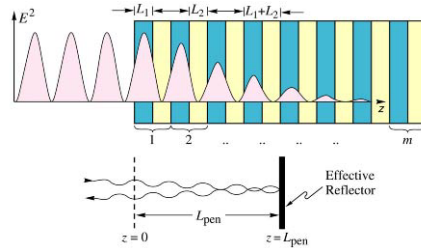
Figure 2. Reflectance spectrum in air of a 1000-nm GaAs/AlAs DBR for 20 periods and 5 periods (lower two plots). Dashed lines show the reflectance from a bare GaAs substrate. Top plot shows the high-reflectance region of the 20-period mirror near the design wavelength.



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## DBR penetration depth $L_{pen}$

in DBRs the opt. wave penetrates into the reflector by one or several quarter-wave pairs



$$r_{DBR} \approx |r_{DBR}| e^{-2i(\beta - \beta_{Bragg})L_{pen}}$$

$$r_{metal}(z=0) = |r_{metal}| e^{2i(2\pi/\lambda)L_{pen}}$$

$$L_1 = \frac{\lambda_{Bragg}}{4n_1} \quad L_2 = \frac{\lambda_{Bragg}}{4n_2} \quad L_{pen} \approx \frac{L_1 + L_2}{4} \frac{n_1 - n_2}{n_1 + n_2}$$



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## Optical mode density in a one - dimensional resonator

spontaneous recombination probability:

$$W_{spont} = \tau_{spont}^{-1} = \int_0^{\infty} W_{spont}^{(l)} \rho(\nu_l) d\nu_l$$

optical mode density:

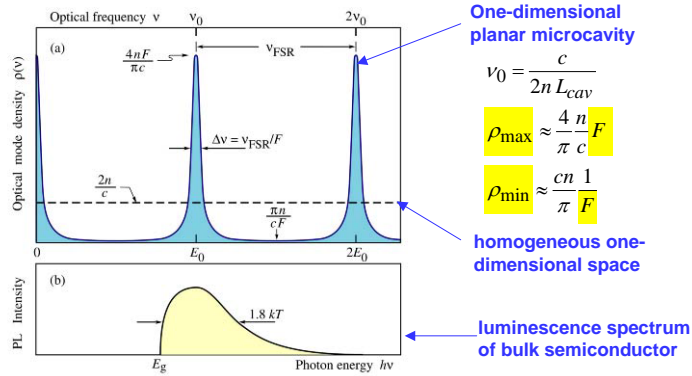
$$\rho^{1D}(\nu) = \frac{2n}{c} \quad (1D \text{ space})$$

$$\rho(\nu) = \frac{(R_1 R_2)^{3/4}}{T_1 T_2} \frac{4n}{c} (1 - \sqrt{R_1 R_2}) T(\nu) \quad (FP \text{ cavity})$$



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## Optical mode density



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## Spectral emission enhancement at $\lambda_{res}$

average emission rate enhancement at the  $\lambda_{res}$  out of both reflectors:

$$G_e = \frac{\rho_{max}}{\rho^{1D}} \approx \frac{2}{\pi} F \approx \left( \frac{2}{\pi} \right) \frac{\pi (R_1 R_2)^{1/4}}{1 - \sqrt{R_1 R_2}}$$

emission rate enhancement out of one single reflector  $R_1$ :

$$G_e \approx \frac{2(1-R_1)}{2-R_1-R_2} \frac{2F}{\pi} \approx \frac{1-R_1}{1-\sqrt{R_1 R_2}} \frac{2F}{\pi} \approx \left( \frac{2}{\pi} \right) \frac{\pi (R_1 R_2)^{1/4} (1-R_1)}{(1-\sqrt{R_1 R_2})^2}$$

standing wave effect – distribution:

$$G_e = \frac{\xi}{2} \left( \frac{2}{\pi} \right) \frac{\pi (R_1 R_2)^{1/4} (1-R_1) \tau_{cav}}{(1-\sqrt{R_1 R_2})^2 \tau}$$

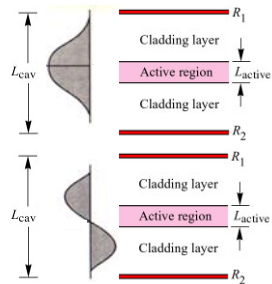
$\frac{\tau_{cav}}{\tau} \geq 0.9$  ....ratio of lifetime with cavity to lifetime without cavity



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## standing wave effect – distribution:

$\xi$  ...antinode enhancement factor



$\xi = 2$  if the active region is located exactly at an antinode

$\xi = 0$  if the active mode is located at a node

$\xi = 1$  if the active mode is smeared out over many periods of the standing wave



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## Integral emission enhancement

**On resonance**, the emission is enhanced along the axis of the cavity. However, sufficiently far **off resonance**, the emission is suppressed.

The **integrated enhancement ratio** (or suppression ratio) can be calculated analytically by assuming a gaussian natural emission

$$G_{int} = G_e \sqrt{\pi \ln 2} \frac{\Delta\lambda}{\Delta\lambda_n}$$

Example:  $R_1=90\%$ ,  $R_2=97\%$ ,  $\xi=1.5$ ,  $\frac{\tau_{cav}}{\tau} \sim 1 \rightarrow F=46$ ,  $G_e=68$   
 with  $\Delta\lambda_{cav}=6.5$  nm,  $\Delta\lambda = 31$  nm  $\rightarrow G_{int}=13$

Experimental enhancement factor  $\sim 5$



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## RCLED design rules

### First design rule

Light-exit mirror should have lower reflectivity than back mirror

$$R_1 \ll R_2$$

### Second design rule

Use shortest possible cavity length  $L_{cav}$ , typical,

$$L_{cav} = \frac{\lambda}{2}$$

### Third design rule

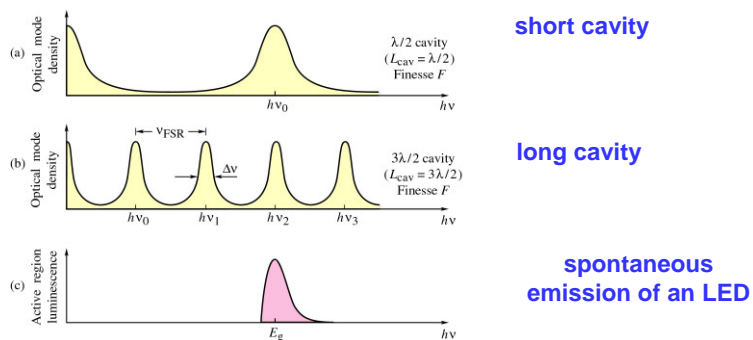
Absorption loss in active region should be smaller than the mirror loss of the light-exit mirror

$$2\xi \alpha L_{cav} < (1 - R_1)$$



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## Second design rule



$$G_{\text{int}} = \frac{\xi}{2\pi} \frac{2}{1 - \sqrt{R_1 R_2}} \sqrt{\pi \ln 2} \frac{\lambda}{\Delta\lambda_n} \frac{\lambda_{cav}}{L_{cav}} \frac{\tau_{cav}}{\tau}$$

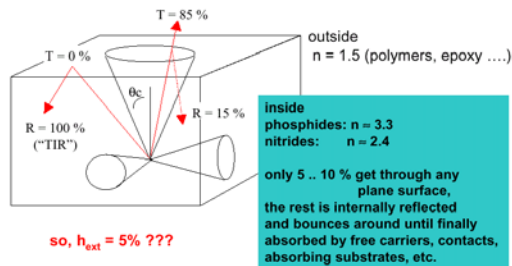


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## Extraction cone



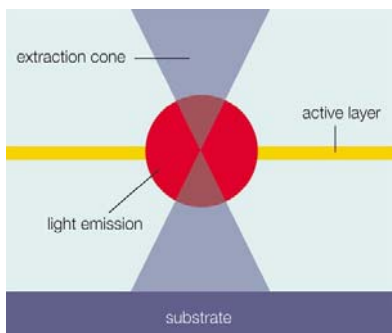
slabs of high refractive index material act as **photon traps**



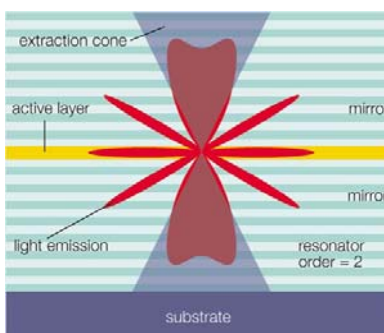
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## Spontaneous emission in LEDs and RCLEDs

isotropic spontaneous emission



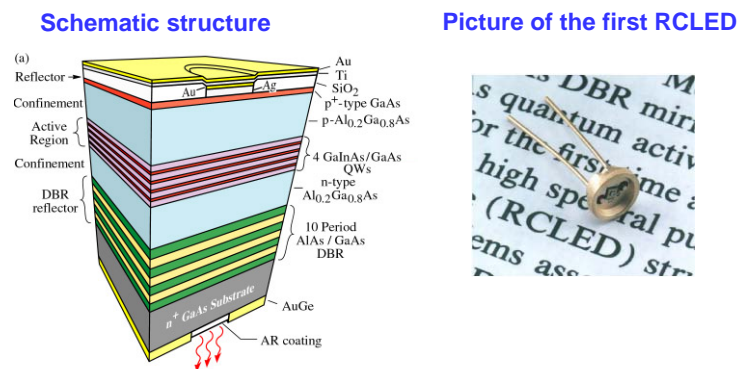
tailored spontaneous emission



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# GalnAs/GaAs RCLEDs (~ 910 nm)

## GalnAs/GaAs RCLED (AlAs/GaAs DBR and Ag top reflector)



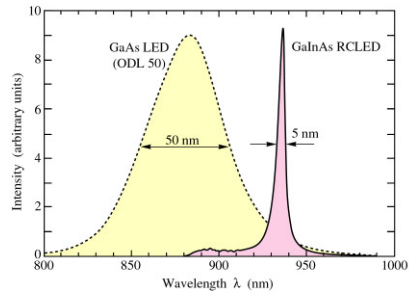
E.F. Schubert et al. (1994)



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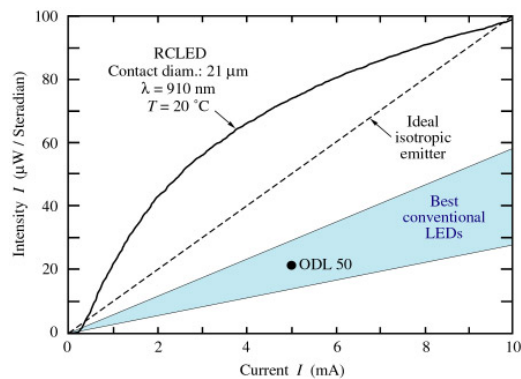
## Comparison of emission spectra

GaAs LED emitting at 870 nm (AT&T ODL 50) and an  
GaInAs RCLED emitting at 930 nm



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## Light versus current curves of GaInAs/GaAs LEDs



RCLED: saturation effects due to carrier overflow and heating

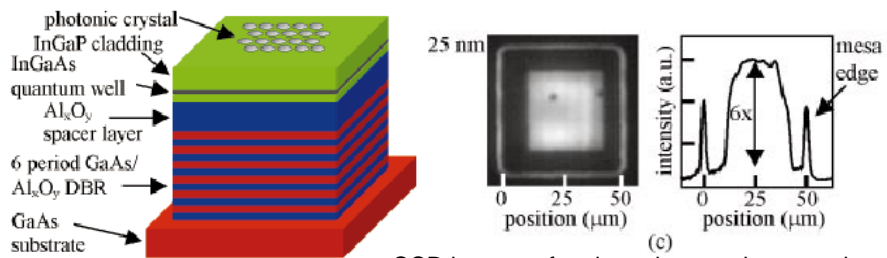


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## Photonic crystals

LED mesa containing a triangular photonic crystal schematic!



CCD images of a photonic crystal centered within a LED mesa at various wavelengths.

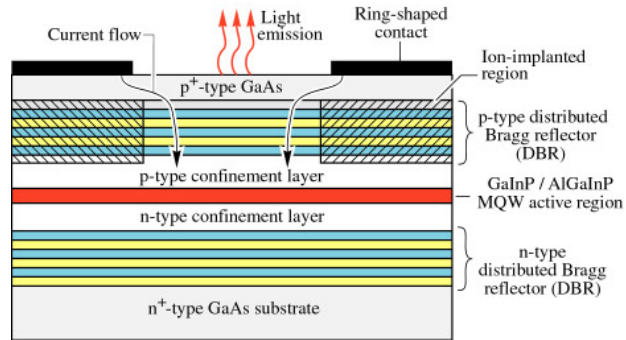
Sixfold intensity enhancement near  $\lambda \sim 925$  nm.



**AlGaInP/GaInP RCLED**  
(~ 650 nm)

## GaNP/AlGaN/P/GaAs MQW RCLED emitting at 650 nm

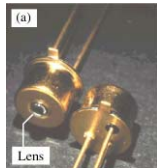
### Schematic structure



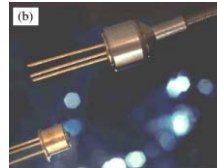
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## AlGaN/P/GaAs RCLED emitting at 650 nm (Mitel Corp., Sweden)

TO packaged RCLED



pigtailed RCLED

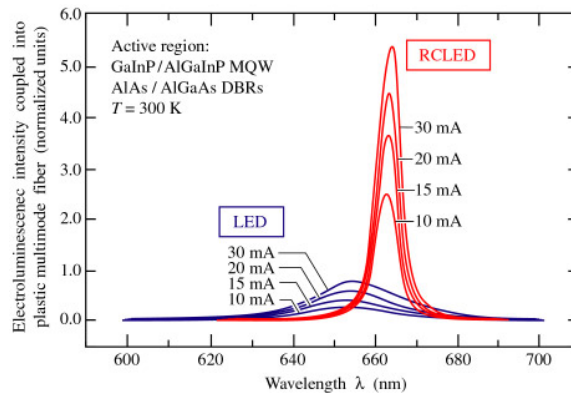


forward-directed emission pattern



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## Spectra of a conventional LED and an RCLED coupled into POF

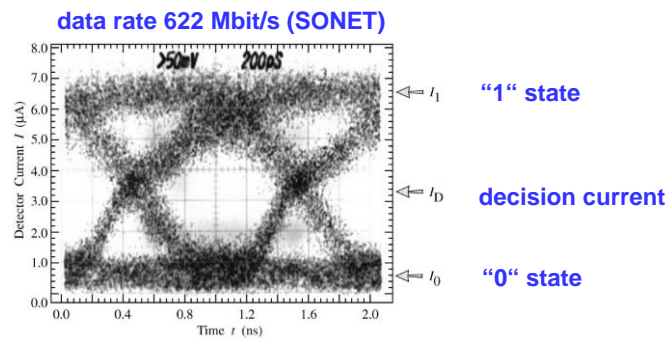


Streubel at al., 1998



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## Eye diagram of the received optical signal of an RCLED



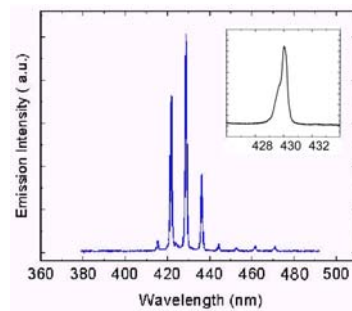
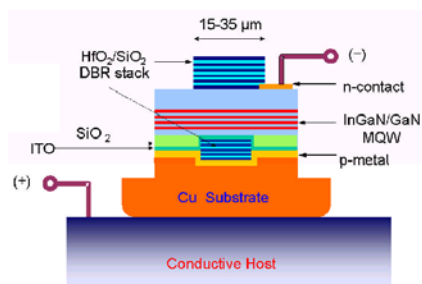
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# InGaN/GaN RCLED

(~ 510 nm)

## Nitride Vertical Cavity QW light emitter (with two dielectric mirrors)

Electrical injected VC InGaN/GaN LED Emission spectrum of blue RCLED



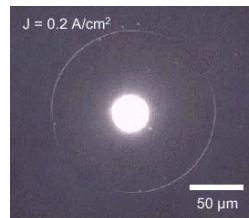
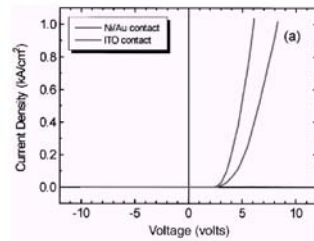
Y.-K. Song et al., APL **77**(12), 1744 (2000)

- modal linewidth = 0.7 nm, Q~ 700
- shorter cavities by ECR etching
- directional emission (~10° cone)



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## I-V and emission pattern



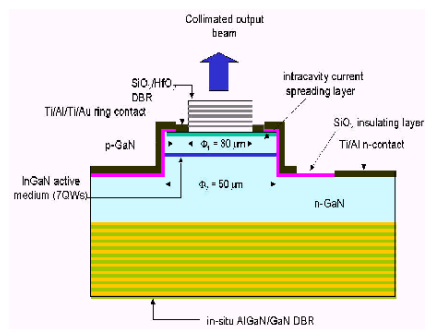
Y.-K. Song et al., APL **77**(12), 1744 (2000)



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## Nitride RCLED

(with one in-situ AlGaIn DBR and one dielectric mirror)

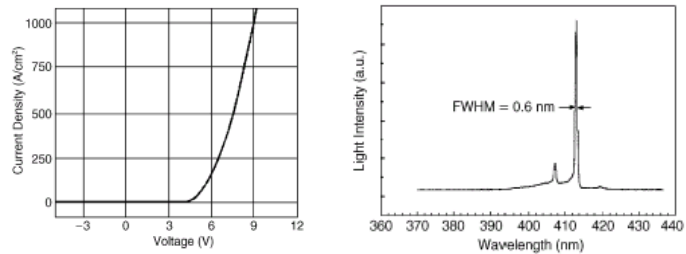


M. Diagne et al., APL **79** (22), 3720(2001)



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## I-V and spectrum of a hybrid RCLED



- monochromatic spectrum
- directional emission

M. Diagne et al., APL **79** (22),3720(2001)



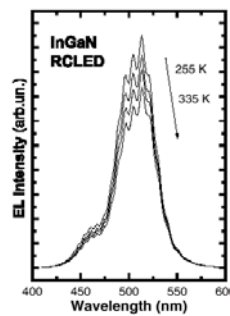
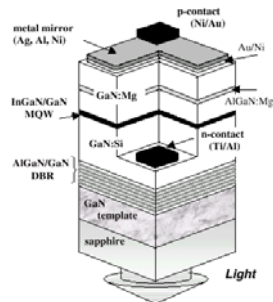
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## Nitride RCLEDs

(one AlGaIn DBR and one metallic mirror)

Nitride RCLED with a  $3\lambda$  cavity

EL-spectra at different temperatures



$$dI/dT = -0.31\% / K$$

$$d\lambda/dT = 0.033 \text{ nm/K}$$

F.Calle et al., phys.stat.sol.(a)**192** (2),277 (2002)



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## Conclusion

**Resonant-cavity light emitting diode** – LED inside an optical cavity

### Advantages of RCLEDs:

- light intensity is higher (enhancement factor 2-10)
- higher spectral purity (determined by Q factor)
- emission far-field pattern more directed
- less chromatic dispersion -> higher bit rates (622 Mbit/s SONET)
- less expensive, reliable and less temperature sensitive than Lasers
- lower manufacturing cost as compared to VCSEL

### Realization of RCLEDs:

- InGaAs/GaAs (~900 nm)
- AlGaInP/GaAs (~650nm) → Communication via POF
- InGaN/GaN (~510nm)



## Muster

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### *Internal, extraction, external, and power efficiency*

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$$\eta_{\text{int}} = \frac{\text{\# of photons emitted from active region per second}}{\text{\# of electrons injected into LED per second}} = \frac{P_{\text{int}} / (h\nu)}{I / e}$$

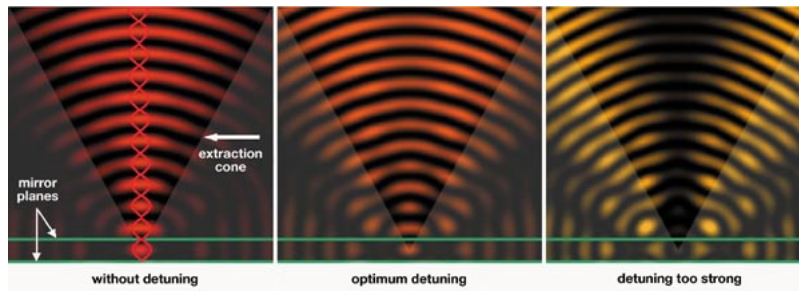
$$\eta_{\text{extraction}} = \frac{\text{\# of photons emitted into free space per second}}{\text{\# of photons emitted from active region per second}}$$

$$\eta_{\text{ext}} = \frac{\text{\# of photons emitted into free space per sec.}}{\text{\# of electrons injected into LED per sec.}} = \frac{P / (h\nu)}{I / e} = \eta_{\text{int}} \eta_{\text{extraction}}$$

$$\eta_{\text{power}} = \frac{P}{IV}$$



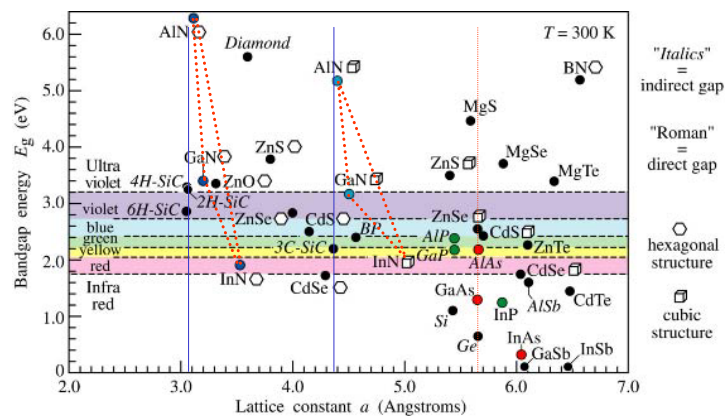
## Wavefield of an RCLED



Light extraction is maximized at optimum detuning, where the wavelength of the emission is slightly shorter than the vertical resonance wavelength.

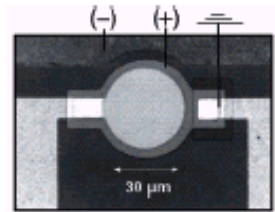


## $E_{\text{gap}}$ vs. Lattice constant

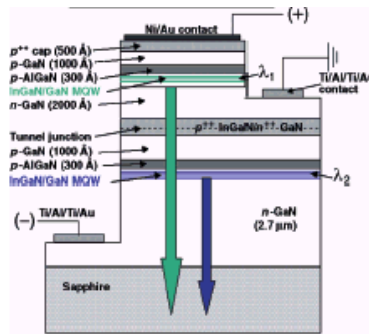


## two-wavelength blue - green LED

Planview photograph

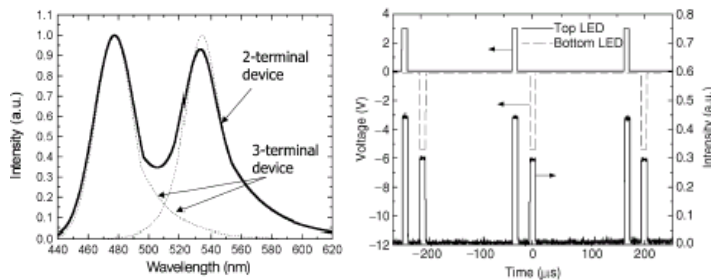


Schematic illustration



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## Blue and green two-terminal LED



Emission spectra from blue and green LEDs when the devices are activated independently in a three-terminal case (dashed curve), and their simultaneous activation as a two-terminal LED (solid Curve). (b) Time sequenced activation of the two LEDs (amplitudes and duty cycle chosen arbitrarily)



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## Optical mode density (mathematical considerations)

$$\rho(\nu) = \frac{(R_1 R_2)^{3/4}}{T_1 T_2} \frac{4n}{c} (1 - \sqrt{R_1 R_2}) T(\nu)$$

$$T(\nu) = \frac{T_1 T_2}{1 + R_1 R_2 - 2\sqrt{R_1 R_2} \cos(4\pi n L_{cav} \nu / c)}$$

$$\rho_{\max} \approx \frac{4n}{\pi c} F = \frac{2}{\pi} \frac{\lambda}{c L_{cav}} Q$$

The mode density at the maximum is proportional to the finesse  $F$  or quality factor  $Q$  of the cavity

$$\rho_{\min} \approx \frac{\pi n}{c} \frac{1}{F} = \frac{2\pi n^2 L_{cav}}{\lambda c} \frac{1}{Q}$$

The mode density at the minima is inversely proportional to the finesse  $F$  or quality factor  $Q$  of the cavity

Mode density is conserved, i.e. the area below the 1D mode density and the 1D cavity mode density is the same



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## Formeln 1

$$L_1 = \frac{\lambda_{\text{Bragg}}}{4n_1} \quad L_{\text{pen}} \approx \frac{L_1 + L_2}{4} \frac{n_1 - n_2}{n_1 + n_2}$$

$$L_2 = \frac{\lambda_{\text{Bragg}}}{4n_2}$$

$$r = \frac{n_1 - n_2}{n_1 + n_2}$$

$$n_{\text{eff}} = 2 \left( \frac{1}{n_1} + \frac{1}{n_2} \right)^{-1}$$

$$\rho_{\max} \approx \frac{4n}{\pi c} F = \frac{2}{\pi} \frac{\lambda}{c L_{cav}} Q$$

$$R_{\text{DBR}} = |r_{\text{DBR}}|^2 = \left( \frac{1 - \left(\frac{n_1}{n_2}\right)^{2m}}{1 + \left(\frac{n_1}{n_2}\right)^{2m}} \right)^2$$

$$r_{\text{DBR}} \approx |r_{\text{DBR}}| e^{-2i(\beta - \beta_{\text{Bragg}}) L_{\text{pen}}}$$

$$r_{\text{metal}}(z=0) = |r_{\text{metal}}| e^{2i(2\pi/\lambda) L_{\text{pen}}}$$

$$\Delta\lambda_{\text{stop band}} = \frac{2 \lambda_{\text{Bragg}} \Delta n}{\pi n_{\text{eff}}}$$



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## Formeln 2

$$\rho(\nu) = \frac{(R_1 R_2)^{3/4}}{T_1 T_2} \frac{4n}{c} (1 - \sqrt{R_1 R_2}) T(\nu)$$

$$\rho_{\max} \approx \frac{4n}{\pi c} F = \frac{2}{\pi c} \frac{\lambda}{L_{\text{cav}}} Q$$

$$T(\nu) = \frac{T_1 T_2}{1 + R_1 R_2 - 2\sqrt{R_1 R_2} \cos(4\pi n L_{\text{cav}} \nu / c)}$$

$$\rho_{\min} \approx \frac{\pi n}{c} \frac{1}{F} = \frac{2\pi n^2}{\lambda c} \frac{L_{\text{cav}}}{Q}$$

$$G_e = \frac{\rho_{\max}}{\rho_{1D}} \approx \frac{2}{\pi} F \approx \left( \frac{2}{\pi} \right) \frac{\pi (R_1 R_2)^{1/4}}{1 - \sqrt{R_1 R_2}}$$

$$G_e \approx \frac{2(1-R_1)}{2-R_1-R_2} \frac{2F}{\pi} \approx \frac{1-R_1}{1-\sqrt{R_1 R_2}} \frac{2F}{\pi} \approx \left( \frac{2}{\pi} \right) \frac{\pi (R_1 R_2)^{1/4} (1-R_1)}{(1-\sqrt{R_1 R_2})^2}$$

$$G_e = \frac{\xi}{2} \left( \frac{2}{\pi} \right) \frac{\pi (R_1 R_2)^{1/4} (1-R_1) \tau_{\text{cav}}}{(1-\sqrt{R_1 R_2})^2 \tau}$$



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